

BLIND FAULT ATTACK AGAINST SPN **CIPHERS** FDTC 2014



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IN BRIEF

- Substitution Permutation Networks (SPN)
- Fault attacks
- Blind fault attack against SPN ciphers
- Results
- Questions

BLOCK CIPHER





FAULT ATTACKS





SUBSTITUTION PERMUTATION NETWORKS

Block cipher construction which uses a sequence of invertible transformations:

- Substitution stage or S-box S (Usually 4-bit or 8-bit S-boxes)
- Permutation stage P
- Key mixing operation A

Structure used by AES, LED, SAFER++, ...



SUBSTITUTION PERMUTATION NETWORKS



Figure : A typical SPN-based block cipher



DIFFERENTIAL FAULT ANALYSIS

- 1. Inject faults in the last rounds of a block cipher
- 2. Collect pairs $(C_1, \tilde{C}_1), (C_2, \tilde{C}_2), ...$
- 3. Apply a statistical method on these pairs and retrieve the key *K*.
- The input messages do not need to be known:

$$egin{aligned} &M_1
ightarrow (C_1, ilde C_1), \ &M_2
ightarrow (C_2, ilde C_2), \end{aligned}$$



DIFFERENTIAL FAULT ANALYSIS





COLLISION FAULT ANALYSIS

The same idea can be applied for inputs:

- 1. Inject faults in the first rounds
- 2. Find colliding input pairs $(M_1, \tilde{M}_1), (M_2, \tilde{M}_2), ...$
- 3. Apply a statistical method on these pairs and retrieve the key *K*.
- The output messages do not have to be known:

 $(M_1, ilde{M_1}) o C_1$ $(M_2, ilde{M_2}) o C_2$

But they have to be somehow compared (equality check $\mathcal{O}(C_1 = C_2)$).



COLLISION FAULT ANALYSIS





CURRENT ATTACKS FOR AES

Attack	Rounds	Plaintexts	Ciphertexts
DFA	6-10	Unknown	Known
CFA	1-2	Known	Unknown*

* equality test check ($\mathcal{O}(C_1 = C_2)$)



BLIND FAULT ATTACK

What if input and output values are not directly accessible ?





EXAMPLES

- Input and output whitening
- Cascade encryption
- Hardware security module









OUR CONTRIBUTION

Attack	Rounds	Plaintexts	Ciphertexts
DFA	6-10	Unknown	Known
CFA	1-2	Known	Unknown*
BFA	Any	Unknown	Unknown*

* equality test check ($\mathcal{O}(C_1 = C_2)$)



ASSUMPTIONS

- 1. A multi-bit set or reset fault can be injected to an internal byte/nibble *X* of a SPN block cipher.
- 2. Unknown plaintexts can be encrypted several times.
- 3. The different faulted or correct outputs can be compared pairwise without revealing their values (pairwise equality check $O(C_1 = C_2)$).



BLIND FAULT ATTACK OVERVIEW

1. For each plaintext:

- 1.1 Introduce faults during a round execution and compare the different outputs.
- 1.2 From the number of different faulted outputs determine the Hamming weights of an algorithm's internal state.
- 2. For each possible key candidate:
 - 2.1 Perform a key search to recover a key byte/nibble.



FAULT MODEL





MULTI-BIT SET/RESET FAULT MODEL

These fault models have been observed in practice:

- Laser fault injection in SRAM: [Roscian, Sarafianos, Dutertre, Tria] FDTC 2013
- Electromagnetic glitch fault injections: [Moro, Dehbaoui, Heydemann, Robisson, Encrenaz] FDTC 2013



HAMMING WEIGHT GUESS





The number of faults injections can be minimized when considered as an "occupancy problem".

The probability that after *l* fault injections, *Y_l* different possible ciphertexts (among *λ* = 2^{*HW*(*X*)}) are received can be considered as the probability that *Y_l* out of *λ* bins are occupied after throwing randomly *l* balls.



OCCUPANCY PROBLEM

$$\Pr(Y_{\ell} = \kappa) = \begin{cases} \frac{\lambda! \alpha_{\kappa,\ell}}{(\lambda - \kappa)! \lambda^{\ell}} & \kappa \in \{1, ..., \min(\lambda, \ell)\} \\ 0 & \text{else} \end{cases}$$

 $\hat{\lambda}$ with maximum likelihood is assumed as correct:

$$\hat{\lambda} = rg\max_{\lambda_i} \mathbf{Pr}(Y_\ell = \kappa | \lambda_i)$$



SIMULATION



15 faults give a 99% success probability for a 4-bit variable.
62 faults give a 99% success probability for a 8-bit variable.

TARGETED STATES





TARGETED STATES





KEY SIFTING

- For each key byte/nibble candidate *K_i*:
 - ▶ if $\nexists X \mathcal{HW}(X) = h_r$ and $\mathcal{HW}(\mathbf{S}_{r+1,j} \circ \mathbf{A} |_{K_i}(X)) = h_{r+1}$: K_i is discarded from the candidate list.
- \Rightarrow A lot of Hamming weight pairs needed to reduce the candidate list
- \Rightarrow Can be improved with key likelihood estimation.



KEY LIKELIHOOD ESTIMATION

It was determined that Hamming weight distribution of key mixing and S-box is unique for the tested ciphers:





KEY LIKELIHOOD ESTIMATION

- 1. Before the attack, the Hamming weight distributions are precomputed for each key candidate.
- 2. The Euclidean distance between the distribution of the recovered Hamming weight pairs and the precomputed distributions is computed for all remaining key candidates.
- 3. The key candidate with the minimal distance is assumed to be correct.



SIMULATIONS

Table : Specification of operation for different ciphers

Cipher	Exact operation		Size
LED	$X_{r+1,j}^{\mathcal{S}} = \mathbf{S} \left[X_{r+1,j}^{\mathcal{S}} \right]$	$K_{r,j} \oplus X_{r,j}^{SP}$	4-bit
AES	$X_{r+1,j}^{\mathcal{S}} = \mathbf{S}$	$K_{r,j} \oplus X_{r,j}^{SP}$	8-bit
SAFER++	$X_{r+1,j}^{\mathcal{S}} = \mathbf{S} \left[X_{r+1,j}^{\mathcal{S}} \right]$	$K_{r,j} + \overline{X_{r,j}^{SP}}$	8-bit



LED SIMULATION





AES SIMULATION





RESULTS

Number of faults used to recover a key byte/nibble:

Cipher	# plaintexts	# faults per plaintext	Total # faults
LED	50	40	2,000
AES	250	120	30,000
SAFER++	200	120	24,000



RESULTS

- Fault attacks are feasible even when input and output messages are not known but ciphertext equality check is available.
- Fault attacks can be applied against any SPN round.
- Fault model is generic and has been observed in practice.
- The total number of faults to recover a key is the price to pay for blindness (480,000 for a complete AES key).



FUTURE DEVELOPEMENTS

- New methods to reduce the number of required fault injections.
- Hamming weight distribution theory.
- Results and problems when applied in practice.











THANK YOU!

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HAMMING WEIGHT PROBABILITY DISTRIBUTION

$\mathbf{Pr}_{k}\left[\mathcal{HW}(x),\mathcal{HW}\left(\mathbf{S}_{r+1,j}\circ\mathbf{A}\mid_{k}(x) ight) ight]$

